

Annually, the Editor-in-Chief of the *ACM Transactions on Multimedia Computing, Communications and Applications (TOMCCAP)* honors one member of the Editorial Board with the *TOMCCAP Associate Editor of the Year Award*. The purpose of the award is the distinction of excellent work for ACM TOMCCAP and hence also for the whole multimedia community in the previous year. Criteria for the award are (1.) the amount of submissions processed in time, (2.) the performance during the reviewing process and (3.) the accurate interaction with the reviewers in order to broaden the awareness for the journal.

Based on the criteria mentioned above, the ACM Transactions on Multimedia Computing, Communications and Applications Associate Editor of the Year Award 2013 goes to Mohan S. Kankanhalli from the National University of Singapore. The Editor-in-Chief Ralf Steinmetz cordially congratulates Mohan.

Mohan Kankanhalli is a Professor at the Department of Computer Science of the National University of Singapore. He is also the Associate Provost for Graduate Education at NUS. Before that, he was the Vice-Dean for Academic Affairs and Graduate Studies at the NUS School of Computing during 2008-2010 and Vice-Dean for Research during 2001-2007. Mohan obtained his BTech from IIT Kharagpur and MS & PhD from the Rensselaer Polytechnic Institute.



His current research interests are in Multimedia Systems (content processing, retrieval) and Multimedia Security (surveillance and privacy). He has been awarded a S\$10M grant by Singapore's National Research Foundation to set up the Centre for "Sensor-enhanced Social Media" (sesame.comp.nus.edu.sg).

Mohan has been actively involved in the organization of many major conferences in the area of Multimedia. He was the Director of Conferences for ACM SIG Multimedia from 2009 to 2013. He is on the editorial boards of several journals including the ACM Transactions on Multimedia Computing, Communications, and Applications, Springer Multimedia Systems Journal, Pattern Recognition Journal and Multimedia Tools & Applications Journal.